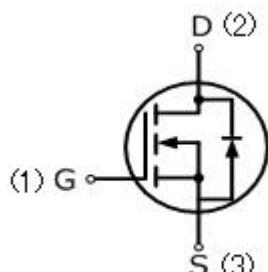


16N65MF

16 Amps, 650 Volts N-CHANNEL MOSFET

FEATURE

- 16A, 650V, $R_{DS(ON)MAX}=0.45\ \Omega$ @ $V_{GS}=10V/8A$
- Low gate charge
- Low C_{iss}
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



TO-220MF



Absolute Maximum Ratings ($T_c=25^\circ C$, unless otherwise noted)

Parameter	Symbol	16N65MF	UNIT
Drain-Source Voltage	V_{DSS}	650	V
Gate-Source Voltage	V_{GSS}	± 30	
Continuous Drain Current	I_D	16	A
Pulsed Drain Current(Note 1)	I_{DM}	64	
Single Pulse Avalanche Energy (Note 2)	E_{AS}	900	mJ
Avalanche Current(Note 1)	I_{AR}	16	A
Repetitive Avalanche Energy (Note 1)	E_{AR}	30	mJ
Reverse Diode dv/dt (Note 3)	dv/dt	4.5	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T_L	260	°C

Thermal Characteristics

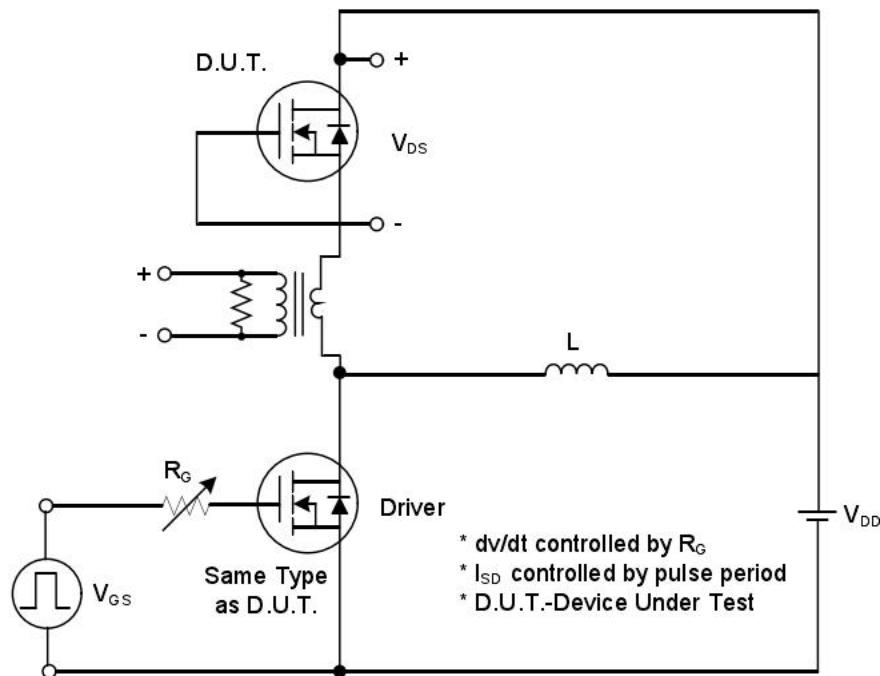
Parameter	Symbol	TO-220MF	Units
Maximum Junction-to-Case	R_{thJC}	3.0	°C/W
Maximum Power Dissipation	$T_c=25^\circ C$	P_D	W

Electrical Characteristics ($T_c=25^\circ\text{C}$, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$	650	—	—	V
Breakdown Temperature Coefficient $/\Delta T_J$	$\Delta \text{BV}_{\text{DSS}}$	Reference to 25°C , $\text{I}_D=250\mu\text{A}$	—	0.6	—	$\text{V}/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}}=650\text{V}, \text{V}_{\text{GS}}=0\text{V}$	—	—	1	μA
Gate-Body Leakage Current, Forward	I_{GSSF}	$\text{V}_{\text{GS}}=30\text{V}, \text{V}_{\text{DS}}=0\text{V}$	—	—	100	nA
Gate-Body Leakage Current, Reverse	I_{GSSR}	$\text{V}_{\text{GS}}=-30\text{V}, \text{V}_{\text{DS}}=0\text{V}$	—	—	-100	nA
On Characteristics						
Gate-Source Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}}=10\text{V}, \text{I}_D=250\mu\text{A}$	2	—	4	V
Drain-Source On-State Resistance	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=8\text{A}$	—	0.33	0.45	Ω
Dynamic Characteristics						
Input Capacitance	C_{iss}	$\text{V}_{\text{DS}}=25\text{V}, \text{V}_{\text{GS}}=0\text{V},$ $f=1.0\text{MHz}$	—	1968	—	pF
Output Capacitance	C_{oss}		—	1047	—	pF
Reverse Transfer Capacitance	C_{rss}		—	73	—	pF
Switching Characteristics						
Turn-On Delay Time	$t_{\text{d(on)}}$	$\text{V}_{\text{DD}}=325\text{V}, \text{I}_D=16\text{A},$ $\text{R}_G=25\Omega$ (Note 4,5)	—	58	—	ns
Turn-On Rise Time	t_r		—	126	—	ns
Turn-Off Delay Time	$t_{\text{d(off)}}$		—	214	—	ns
Turn-Off Fall Time	t_f		—	49	—	ns
Total Gate Charge	Q_g		—	63	—	nC
Gate-Source Charge	Q_{gs}	$\text{V}_{\text{DS}}=480\text{V}, \text{I}_D=16\text{A},$ $\text{V}_{\text{GS}}=10\text{V}$, (Note 4,5)	—	11	—	nC
Gate-Drain Charge	Q_{gd}		—	29	—	nC
Drain-Source Body Diode Characteristics and Maximum Ratings						
Continuous Diode Forward Current	I_S		—	—	16	A
Pulsed Diode Forward Current	I_{SM}		—	—	64	A
Diode Forward Voltage	V_{SD}	$\text{I}_S=16\text{A}, \text{V}_{\text{GS}}=0\text{V}$	—	—	1.5	V
Reverse Recovery Time	t_{rr}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_S=16\text{A},$ $d\text{I}_F/dt=100\text{A/us}$, (Note 4)	—	483	—	ns
Reverse Recovery Charge	Q_{rr}		—	8.9	—	μC

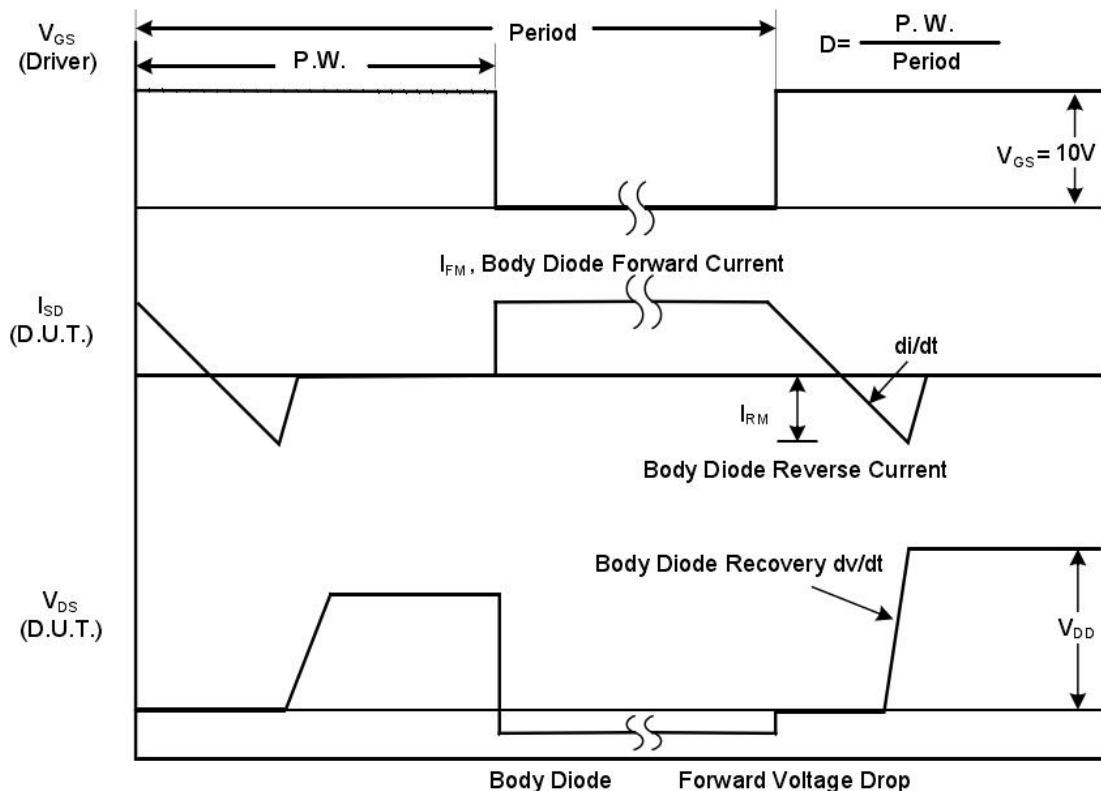
Notes

- Repetitive Rating; pulse width limited by maximum junction temperature.
- $L=10\text{mH}, R_g=25\Omega, I_{AS}=16\text{A}$, starting $T_J=25^\circ\text{C}$.
- $I_{SD} \leq I_D, dI/dt = 200\text{A/us}, V_{DD} \leq \text{BV}_{\text{DSS}}$, starting $T_J=25^\circ\text{C}$.
- Pulse width $\leq 300\text{us}$; duty cycle $\leq 2\%$.
- Repetitive rating; pulse width limited by maximum junction temperature.

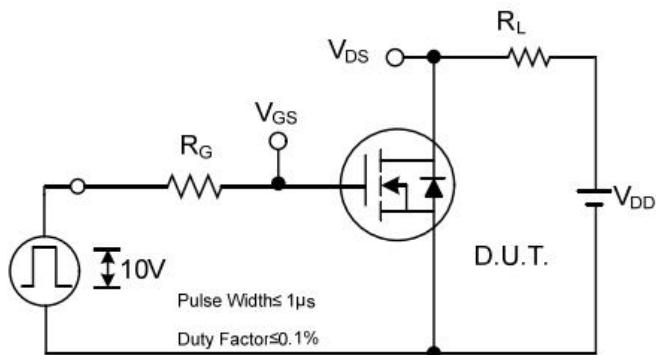
RATING AND CHARACTERISTIC CURVES



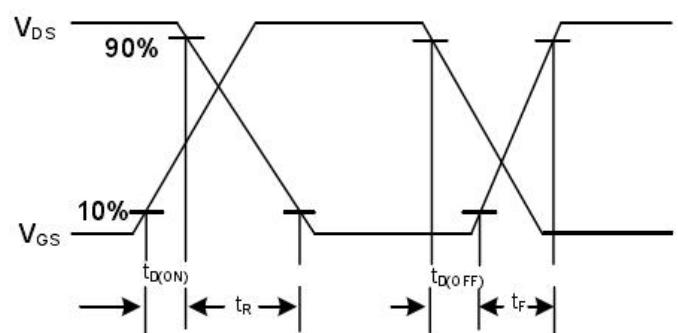
Peak Diode Recovery dv/dt Test Circuit



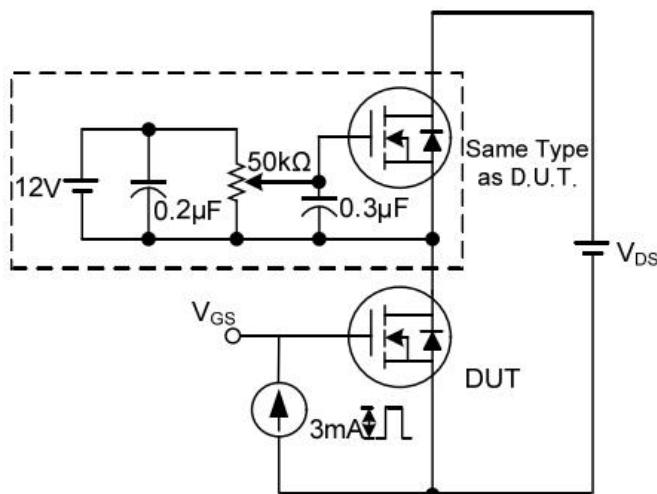
Peak Diode Recovery dv/dt Waveforms



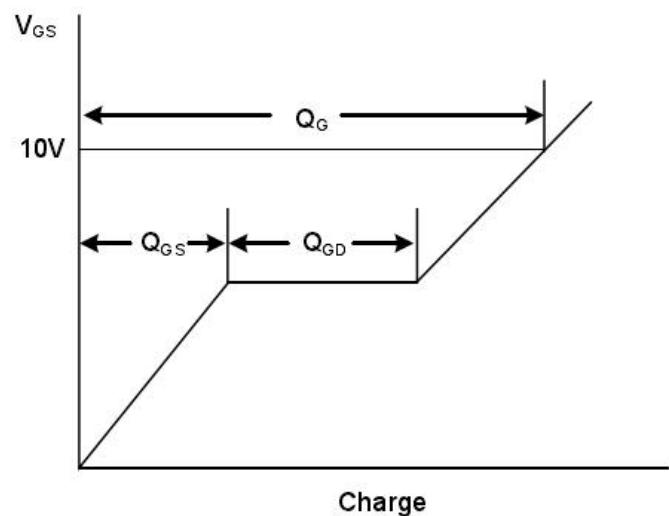
Switching Test Circuit



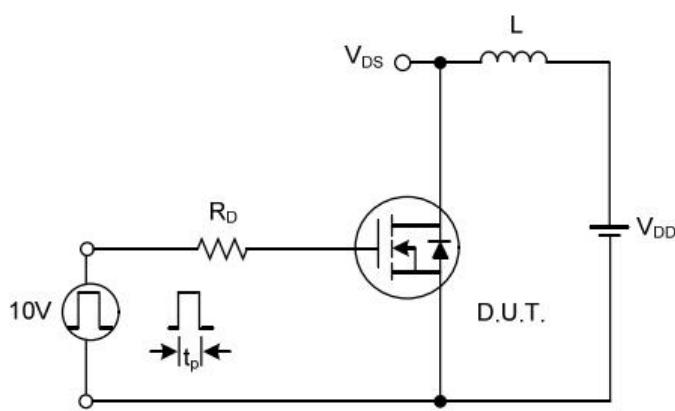
Switching Waveforms



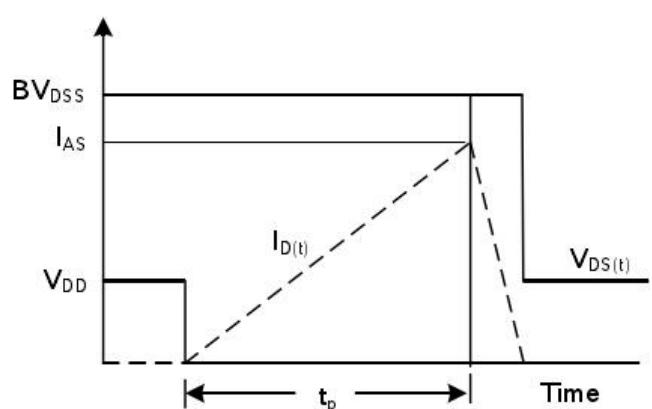
Gate Charge Test Circuit



Gate Charge Waveform

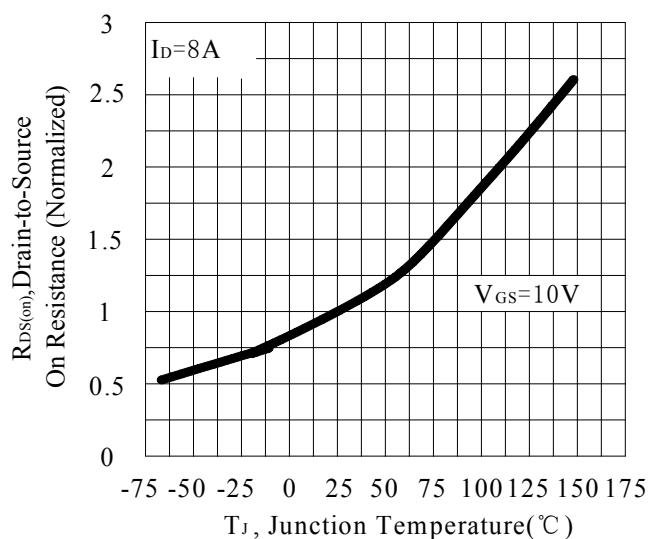
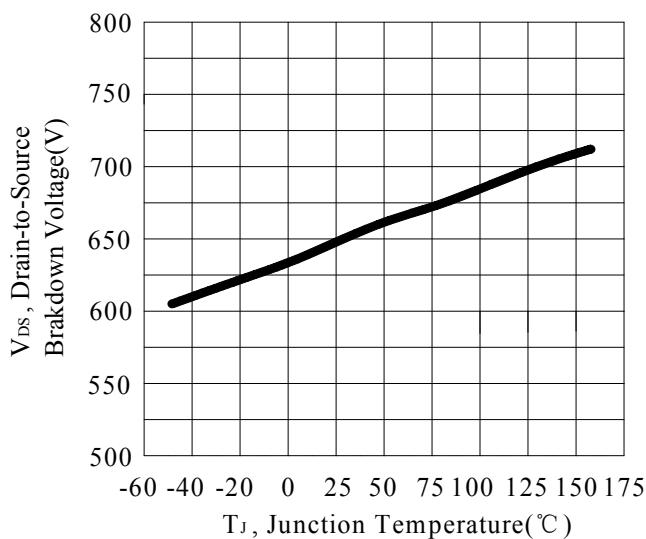
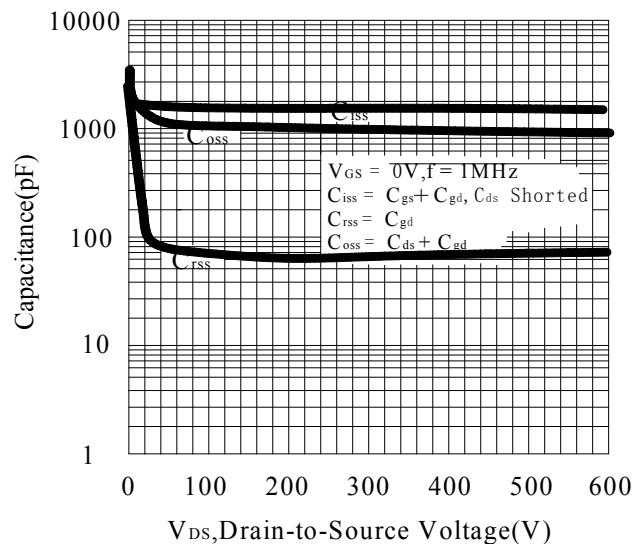
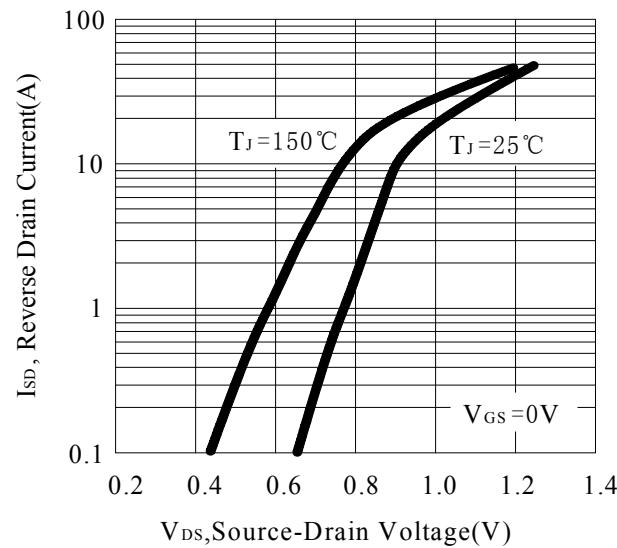
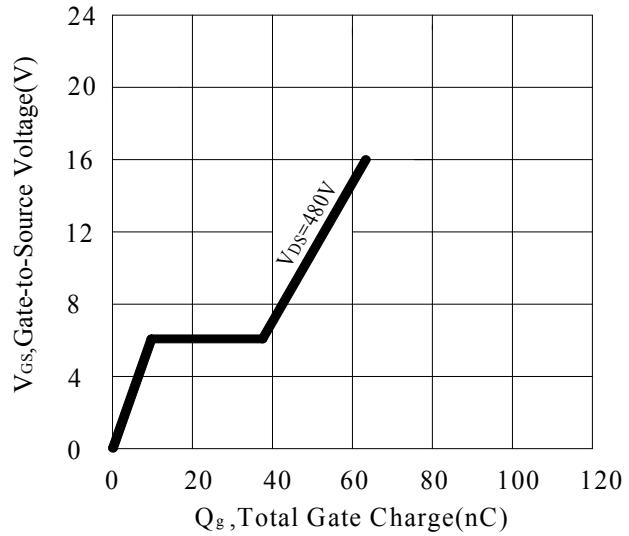
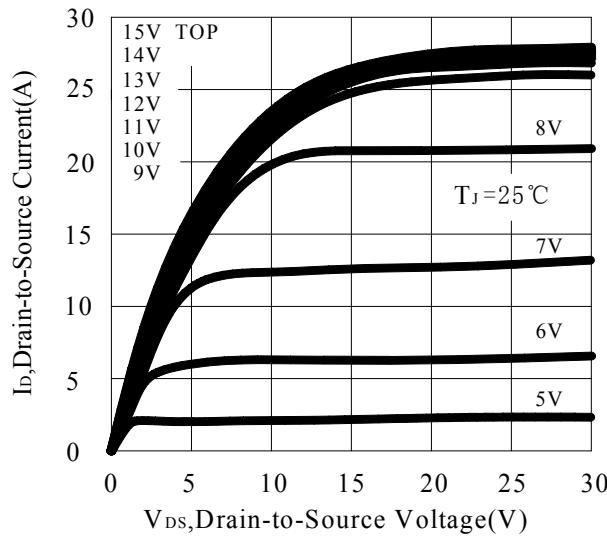


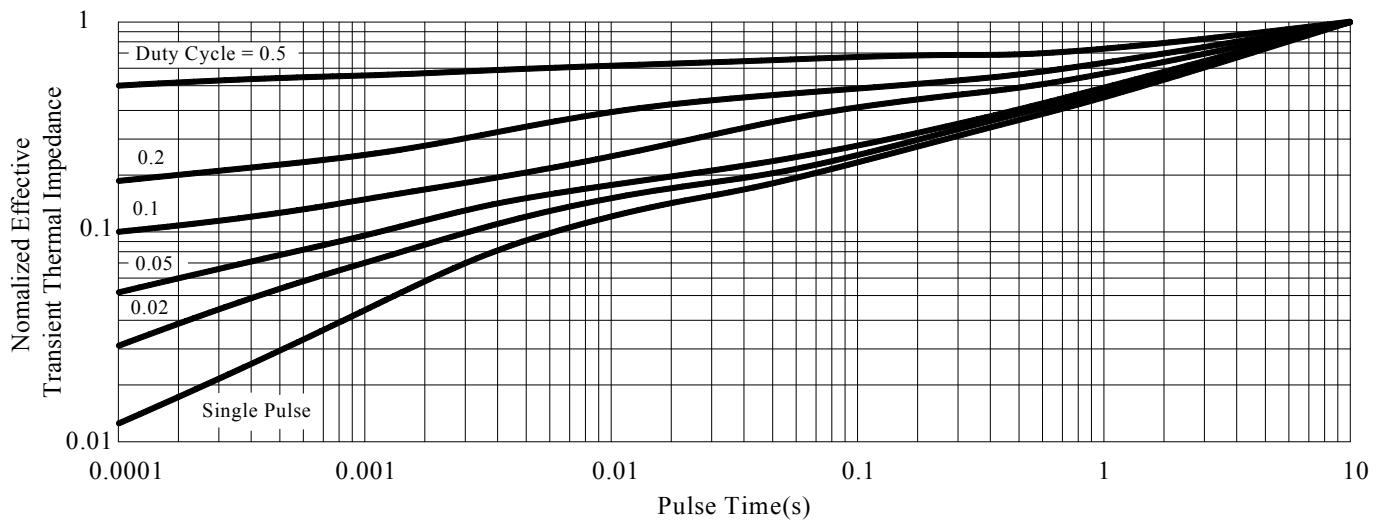
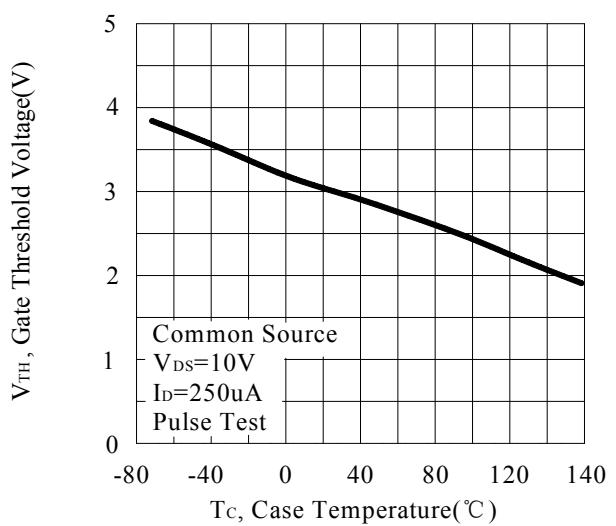
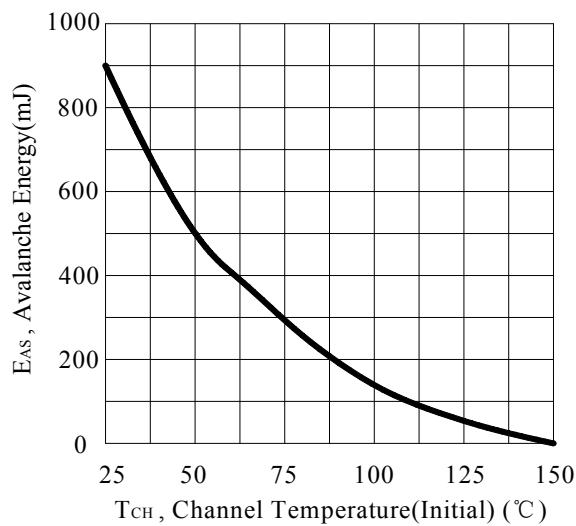
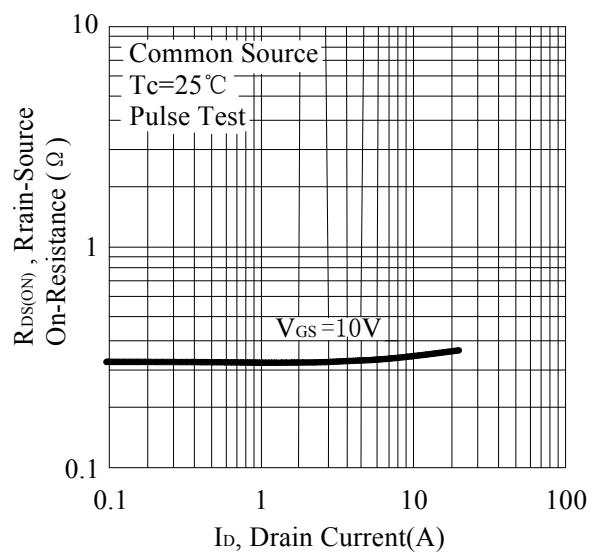
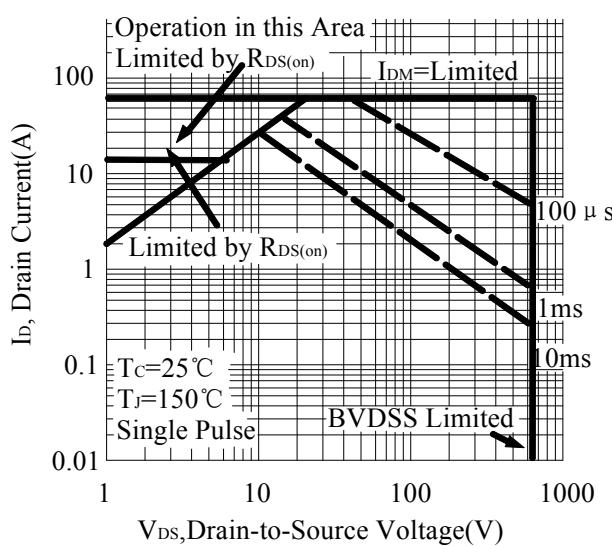
Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

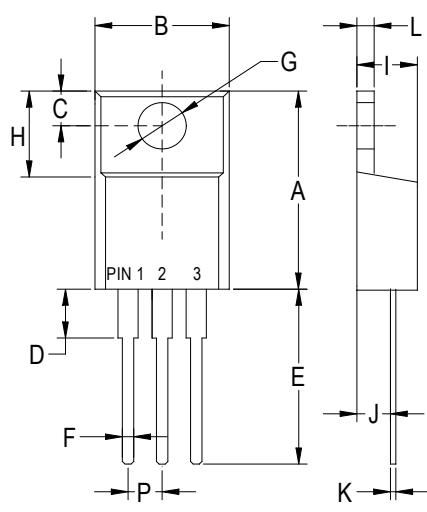
RATING AND CHARACTERISTIC CURVES





PACKAGE OUTLINE DIMENSIONS

TO-220MF



TO-220MF		
Dim	Min	Max
A	.590(15.0)	.650(16.5)
B	.393(10.0)	.414(10.5)
C	.118(3.00)	.138(3.50)
D	.118(3.00)	.146(3.70)
E	.512(13.0)	.551(14.0)
F	.028(0.70)	.035(0.90)
G	.114(2.90)	.138(3.50)
H	.255(6.50)	.280(7.10)
I	.173(4.40)	.197(5.00)
J	.102(2.60)	.110(2.80)
K	.018(0.45)	.026(0.65)
L	.092(2.35)	.109(2.75)
P	.890(2.25)	.113(2.85)

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